

Notice of References Cited	Application/Control No. 10/616,353	Applicant(s)/Patent Under Reexamination VOSNIAK ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0099571	07-2002	Waku et al.	705/2
*	B	US-2004/0089710	05-2004	Moriyama, Naoto	235/375
*	C	US-6,505,064	01-2003	Liu et al.	600/420
*	D	US-2004/0073456	04-2004	Gottlieb et al.	705/002
*	E	US-2003/0093296	05-2003	Lee et al.	705/2
*	F	US-2004/0114714	06-2004	Minyard et al.	378/037
*	G	US-2003/0179245	09-2003	Akagi, Eiichi	345/804
*	H	US-2005/0114181	05-2005	Gottlieb, Ronald H.	705/002
*	I	US-2004/0138925	07-2004	Zheng, Shu Sean	705/002
*	J	US-2004/0249676	12-2004	Marshall et al.	705/002
*	K	US-2002/0091765	07-2002	Bocionek, Siegfried	709/203
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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